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Thank you for your cooperation and understanding,

Ampleon

# **Avionics LDMOS transistor**

# BLA1011-10

### **FEATURES**

- · High power gain
- · Easy power control
- Excellent ruggedness
- Source on mounting base eliminates DC isolators, reducing common mode inductance.

# **APPLICATIONS**

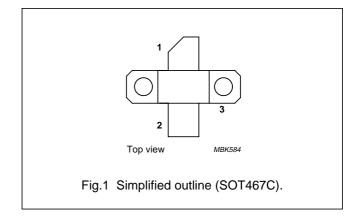
 Avionics transmitter applications in the 1030 to 1090 MHz frequency range.

### **DESCRIPTION**

Silicon N-channel enhancement mode lateral D-MOS transistor encapsulated in a 2-lead flange package (SOT467C) with a ceramic cap. The common source is connected to the flange.

#### **PINNING - SOT467C**

PIN	DESCRIPTION				
1	drain				
2	gate				
3	source, connected to flange				



### **QUICK REFERENCE DATA**

RF performance at  $T_h$  = 25 °C in a common source test circuit.

MODE OF OPERATION	f	V <sub>DS</sub>	P <sub>L</sub>	G <sub>p</sub>	η <sub>D</sub>	
	(MHz)	(V)	(W)	(dB)	(%)	
Pulsed class-AB; $t_p = 50 \ \mu s; \ \delta = 2 \ \%$	1030 to 1090	36	10	>15	>40	

### **ORDERING INFORMATION**

TYPE NUMBER		PACKAGE				
TIPE NOWIDER	NAME	NAME DESCRIPTION VERSI				
BLA1011-10	_	flanged LDMOST ceramic package; 2 mounting holes; 2 leads	SOT467C			

# LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>DS</sub>	drain-source voltage		_	75	V
$V_{GS}$	gate-source voltage		_	±15	V
I <sub>D</sub>	drain current (DC)		_	2.2	Α
P <sub>tot</sub>	total power dissipation	T <sub>h</sub> ≤ 25 °C	_	25	W
T <sub>stg</sub>	storage temperature		-65	+150	°C
Tj	junction temperature		_	200	°C

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### THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
Z <sub>th(j-mb)</sub>	thermal impedance from junction to mounting base	T <sub>mb</sub> = 25 °C; note 1	1.2	K/W
R <sub>th(mb-h)</sub>	thermal resistance from mounting base to heatsink	note 2	0.55	K/W

### **Notes**

- 1. Thermal impedance is determined under RF operating conditions with pulsed bias.
- 2. Typical value for SOT467C mounted with thermal compound and 0.6 Nm fastening torque.

### **CHARACTERISTICS**

 $T_i = 25$  °C unless otherwise specified.

SYMBOL	PARAMETER	PARAMETER CONDITIONS				UNIT
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	$V_{GS} = 0$ ; $I_D = 0.7 \text{ mA}$	75	_	_	V
$V_{GSth}$	gate-source threshold voltage	V <sub>DS</sub> = 10 V; I <sub>D</sub> = 20 mA	4	_	5	V
I <sub>DSS</sub>	drain-source leakage current	V <sub>GS</sub> = 0; V <sub>DS</sub> = 28 V	_	_	0.1	mA
I <sub>DSX</sub>	on-state drain current	$V_{GS} = V_{GSth} + 9 \text{ V}; V_{DS} = 10 \text{ V}$	2.8	_	_	Α
I <sub>GSS</sub>	gate leakage current	$V_{GS} = \pm 15 \text{ V}; V_{DS} = 0$	_	_	40	nA
g <sub>fs</sub>	forward transconductance	V <sub>DS</sub> = 10 V; I <sub>D</sub> = 0.75 A	_	0.5	_	S
R <sub>DSon</sub>	drain-source on-state resistance	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 0.75 A	_	1.2	_	Ω

### **APPLICATION INFORMATION**

RF performance in a common source class-AB circuit.  $T_h$  = 25 °C;  $R_{th\ mb-h}$  = 0.55 K/W unless otherwise specified.

MODE OF OPERATION	f	V <sub>DS</sub>	I <sub>DQ</sub>	P <sub>L</sub>	G <sub>p</sub>	η <sub>D</sub>	t <sub>r</sub>	t <sub>f</sub>	PULSE DROOP
	(MHz)	(V)	(mA)	(W)	(dB)	(%)	(ns)	(ns)	(dB)
Pulsed class-AB; $t_p = 50 \mu s; \delta = 2\%$	1030 to 1090	36	50	10	>15	>40	<20	<20	<0.5

# Ruggedness in class-AB operation

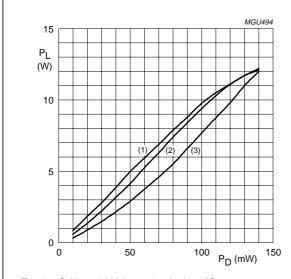
The BLA1011-10 is capable of withstanding a load mismatch corresponding to VSWR = 5: 1 through all phases under the operating conditions.

### Typical impedance values

FREQUENCY (MHz)	Z <sub>S</sub> (Ω)	Z <sub>L</sub> (Ω)
1030	1 + j 10.6	4.3 + j 7
1060	1.3 + j 6.99	5.99 + j 13.98
1090	1.42 + j 7	7 + j 11.58

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 $T_h = 25$  °C;  $V_{DS} = 36$  V;  $I_{DQ} = 50$  mA; class-AB;  $t_p = 50 \ \mu s; \ \delta = 2\%.$ 

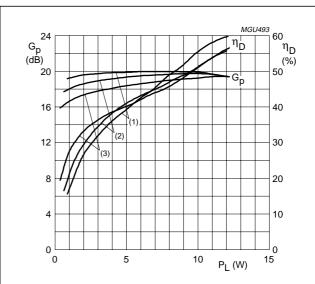
(1) f = 1090 MHz.

(2) f = 1060 MHz.

(3) f = 1030 MHz.

Fig.2 Load power as a function of drive power;

typical values.



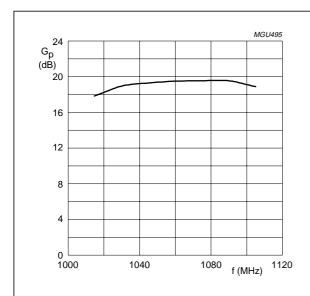
 $T_h$  = 25 °C;  $V_{DS}$  = 36 V;  $I_{DQ}$  = 50 mA; class-AB;  $t_p$  = 50  $\mu s;$   $\delta$  = 2%.

(1) f = 1090 MHz.

(2) f = 1060 MHz.

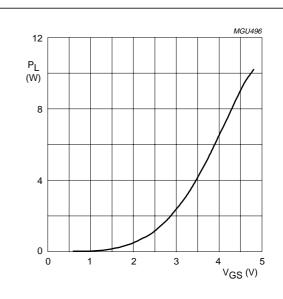
(3) f = 1030 MHz.

Fig.3 Power gain and efficiency as functions of load power; typical values.



 $T_h$  = 25 °C;  $V_{DS}$  = 36 V;  $I_{DQ}$  = 50 mA; class-AB;  $P_L$  = 10 W;  $t_p$  = 50  $\mu s; \, \delta$  = 2%.

Fig.4 Power gain as a function of frequency; typical values.

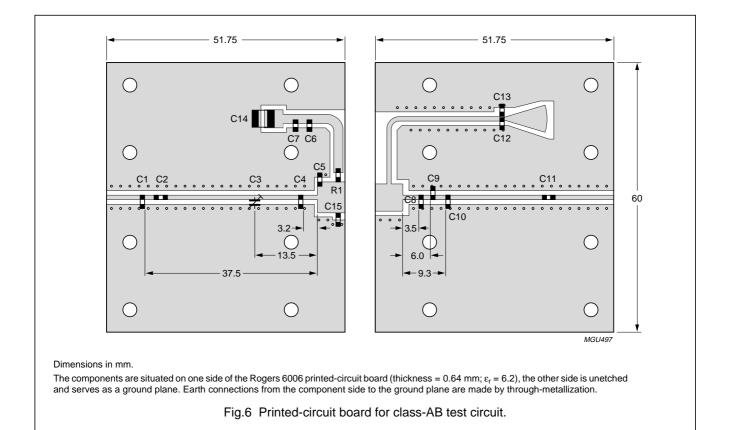


 $T_h$  = 25 °C;  $V_{DS}$  = 36 V;  $I_{DQ}$  = 50 mA; class-AB; f = 1090 MHz;  $t_p$  = 50  $\mu s;$   $\delta$  = 2%.

Fig.5 Load power as a function of gate-source voltage; typical values.

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# List of components for class-AB test circuit (see Fig.6)

COMPONENT	DESCRIPTION	VALUE
C1	multilayer ceramic chip capacitor; note 1	2.7 pF
C2, C11	multilayer ceramic chip capacitor; note 1	56 pF
C3	tekelec trimmer; type 37293	0.8 to 8 pF
C4	multilayer ceramic chip capacitor; note 1	3.6 pF
C5	multilayer ceramic chip capacitor; note 1	6.2 pF
C6	multilayer ceramic chip capacitor; note 1	2 pF
C7, C13	multilayer ceramic chip capacitor; note 1	62 pF
C8	multilayer ceramic chip capacitor; note 1	11 pF
C9	multilayer ceramic chip capacitor; note 1	1.5 pF
C10	multilayer ceramic chip capacitor; note 1	6.2 pF
C12	multilayer ceramic chip capacitor; note 2	20 nF
C14	electrolytic capacitor	4.7 μF; 50 V
C15	multilayer ceramic chip capacitor; note 1	36 pF
R1	SMD resistor (0805)	22 Ω

### **Notes**

- 1. American Technical Ceramics type 100A or capacitor of same quality.
- 2. American Technical Ceramics type 200B or capacitor of same quality.

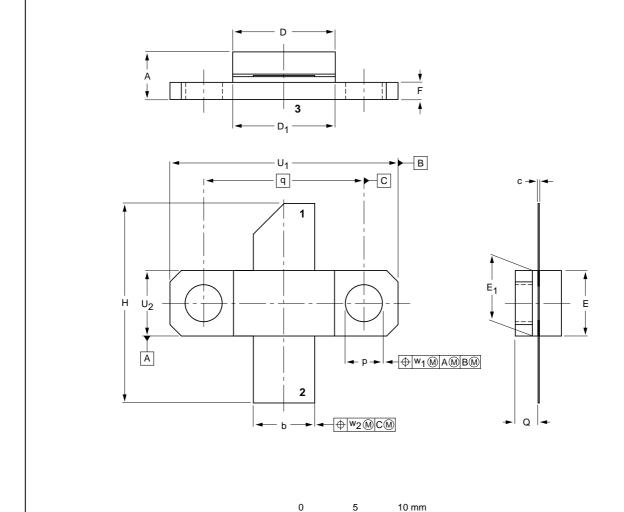
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# **PACKAGE OUTLINE**

# Flanged LDMOST ceramic package; 2 mounting holes; 2 leads

**SOT467C** 



# DIMENSIONS (millimetre dimensions are derived from the original inch dimensions)

UNIT	Α	b	С	D	D <sub>1</sub>	E	E <sub>1</sub>	F	H	р	Q	q	U <sub>1</sub>	U <sub>2</sub>	w <sub>1</sub>	w <sub>2</sub>
mm	4.67 3.94	5.59 5.33	0.15 0.10	9.25 9.04	9.27 9.02	5.92 5.77	5.97 5.72	1.65 1.40	18.54 17.02	3.43 3.18	2.21 1.96	14.27	20.45 20.19	5.97 5.72	0.25	0.51
inch	0.184 0.155		0.006 0.004						0.73 0.67	0.135 0.125	0.087 0.077	0.562	0.805 0.795		0.010	0.020

OUTLINE		REFER	EUROPEAN	ICCUE DATE		
VERSION	IEC	IEC JEDEC EIAJ			PROJECTION	ISSUE DATE
SOT467C						<del>99-12-06</del> 99-12-28

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### **DATA SHEET STATUS**

LEVEL	DATA SHEET STATUS <sup>(1)</sup>	PRODUCT STATUS <sup>(2)(3)</sup>	DEFINITION
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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- 3. For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

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# **CAUTION**

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling. For further information, refer to Philips specs.: SNW-EQ-608, SNW-FQ-302A and SNW-FQ-302B.

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